

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0037474	02-2008	Niwano, Kazuhito	370/335
	B	US-			
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FOREIGN PATENT DOCUMENTS

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